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This report will not be used for social proof function in China market.

Test report No: 6060146.50V1.2

TEST REPORT

Electromagnetic Compatibility (EMC)

Identification of item tested	Air Pump
Trademark	N/A
Model and /or type reference	#62098, #62145
Ratings	220-240 V~; #62145 210W / #62098 190W
Test Laboratory / address	DEKRA Testing and Certification (Shanghai) Ltd.
	3 F., No. 250 Jiangchangsan Road, Jing'an District, Shanghai City, 200436, China
Applicant's name / address	Bestway (Hongkong) International Ltd
	Suite 713, 7/Floor, East Wing, Tsim Sha Tsui Centre, 66 Mody Road, Kowloon, Hongkong
Test method requested, standard	EN 55014-1:2006+A1:2009+A2:2011
	EN 55014-1:2017
	EN 55014-2:2015;
	EN 61000-3-2:2014
	EN 61000-3-3:2013
Verdict Summary	IN COMPLIANCE
Tested by (name / position & signature)	Xingyu He
	Test Engineer Test Engineer
Approved by (name / position & signature)	Zuyao Fan Zuyaw. Fan Project Manager
	Project Manager
Date of issue	2020-04-14
Report template No	TRF_EN55014-1_EN55014-2_EMC01 V1.0

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COMPETENCES AND GUARANTEES

DEKRA is a testing laboratory competent to carry out the tests described in this report.

In order to assure the traceability to other national and international laboratories, DEKRA has a calibration and maintenance program for its measurement equipment.

DEKRA guarantees the reliability of the data presented in this report, which is the result of the measurements and the tests performed to the item under test on the date and under the conditions stated in the report and it is based on the knowledge and technical facilities available at DEKRA at the time of performance of the test.

DEKRA is liable to the client for the maintenance of the confidentiality of all information related to the item under test and the results of the test.

The results presented in this Test Report apply only to the particular item under test established in this document.

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GENERAL CONDITIONS

- 1. This report is only referred to the item that has undergone the test.
- 2. This report does not constitute or imply on its own an approval of the product by the Certification Bodies or Competent Authorities.
- 3. This document is only valid if complete; no partial reproduction can be made without previous written permission of DEKRA.
- 4. This test report cannot be used partially or in full for publicity and/or promotional purposes without previous written permission of DEKRA.

UNCERTAINTY

For all measurements where guidance for the calculation of the instrumentation uncertainty of a measurement is specified in EN 55016-4-2 (CISPR 16-4-2), EN/IEC 61000-4 series or a product standard, the measurement instrumentation uncertainty has been calculated and applied in accordance with these standards.

Uncertainties have been calculated according to the DEKRA internal document. The reported expanded uncertainties are based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%. Refer to the Annex 1 for furter information.

ENVIRONMENTAL CONDITIONS

The climatic conditions during the tests are within the limits specified by the manufacturer for the operation of the EUT and the test equipment. The climatic conditions during the tests were within the following limits:

Ambient temperature	15 °C – 35 °C
Relative Humidity air	30% - 60%
Atmospheric pressure	86 kPa – 106 kPa

If explicitly required in the basic standard or applied product / product family standard the climatic values are recorded and documented separately in this test report.

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POSSIBLE TEST CASE VERDICTS

Test case does not apply to test object	N/A
Test object does meet requirement	P (Pass) / PASS
Test object does not meet requirement	F (Fail) / FAIL
Not measured	N/M

DEFINITION OF SYMBOLS USED IN THIS TEST REPORT

☐ Indicates that the listed condition, standard or equipment is applicable for this report/test/EUT.				
☐ Indicates that the listed condition, standard or equipment is not applicable for this report/test/EUT.				
Decimal separator used in this report		Comma (,)	\boxtimes	Point (.)

ABBREVIATIONS

For the purposes of the present document, the following abbreviations apply:

EUT : Equipment Under Test

QP : Quasi-Peak
CAV : CISPR Average

AV : Average

CDN : Coupling Decoupling NetworkSAC : Semi-Anechoic Chamber

OATS : Open Area Test Site

BW: Bandwidth

AM : Amplitude Modulation

PM : Pulse Modulation

HCP : Horizontal Coupling PlaneVCP : Vertical Coupling Plane

U_N : Nominal voltageN/A : Not ApplicableN/M : Not Measured

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DOCUMENT HISTORY

Report nr.	Date	Description
6060146.50	2019-10-16	First release.
6060146.50V1.1	2019-11-19	Second release.
6060146.50V1.2	2020-04-14	Third release.

REMARKS AND COMMENTS

The equipment under test (EUT) does meet the essential requirements of the stated standard(s)/test(s).

The test results relate only to the samples tested.

According to the declaration from manufacturer, both models are identical except the model name

The test results stated in this report of model #62145 are also representative for the others.

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1 GENERAL INFORMATION

1.1 General Description of the Item(s)

		ĺ				
Descri	ption of the item:	Air Pur	mp			
Model	/ Type number:	#62098	8, #62145			
Serial	number:	N/A				
Trader	nark:	N/A				
Manufa	acturer:	Bestwa	ay Inflatables & Mat	erial Co	rp	
		No. 30	65 Cao An Road , S	Shangha	ai 201812 , P. R. Chi	na
Factor	y:	GOLE	ADER INDUSTRIES	S (JINH	UA) CO., LTD.	
				an Deve	elopment New Zone,	Jinhua, Zhejiang
		Provin	ce, 321025, China.			
F		•				
Rated	power supply:	Voltag	e and Frequency		Refe	erence poles
		vollag	o ana i roquono,		L1 L2	L3 N PE
		\boxtimes	AC: 220-240 V~			
			AC: 100 – 240 V, 5	0/60 Hz		
			DC: 12 V, 24 V, 12	/ 24 V		
			Battery: 12 V			
Rated	Power:	#6214	5 210W /# 62098 19	90W		
Clock	frequencies:	N/A				
	parameters:	N/A				
	ing position:		Table top equipmer	nt		
	3 1	Wall/Ceiling mounted equipment				
			Floor standing equi			
		Hand-held equipment				
		Other:				
			Other.			
Intend	ed use of the Equipment Under	Test (F	IIT)			
	oparatus as supplied for the tes	•	,	acidant	ial and commercial u	usa. Thasa products
	o electronic control unit	l 13 All F	ump, intended for i	esiderit	iai and commercial d	ise. These products
No	Module/parts of test item				Туре	Manufacturer
1	N/A					
No	Documents as provided by the	e applica	ant - Description		File name	Issue date
N/A						
	cations to the test item testing:	\boxtimes	N/A		Supplemental infor	mation:

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Copy of marking plate:	
N/A	

1.2 Environment

The requirements and standards apply to equipment intended for use in:

\boxtimes	Residential (domestic) environment.
\boxtimes	Commercial and light-industrial environment.
	Industrial environment.

1.3 Test data

Test Location	DEKRA Testing and Certification (Shanghai) Ltd. 1 F, No. 250, Jiangchangsan Road, Shanghai City
Date(receive sample)	2019-11
Date (start test)	2019-11
Date (finish test)	2019-11

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1.4 Classification according to EN 55014-2

The standard EN 55014-2 is subdivided in four categories. For each category, specific immunity requirements are formulated.

Category I: Apparatus containing no electronic control circuitry.
<u>Examples:</u> Motor operated appliances, lighting toys, track sets without electronic control units, tools, heating appliances, UV and IR radiators and apparatus containing components such as electromechanical switches and thermostats.
Electric circuits consisting of passive components (such as radio interference suppression capacitors or inductors, mains transformers and mains frequency rectifiers) are not considered to be electronic control circuitry.
<u>Category II:</u> transformer toys, dual supply toys, mains powered motor operated appliances, tools, heating appliances and similar electric apparatus (for example – UV radiators, IR radiators and microwave ovens) containing electronic control circuitry with no clock frequency higher than 15 MHz. (For toys, examples include educational computers, organs, track sets with electronic control units.)
Category III: equipment which in normal use, is not connected to a power network and has no cables attached. This category includes apparatus provided with rechargeable batteries, solar or other similar d.c. power sources which can be charged or operated by connecting the apparatus to the mains power. However, this apparatus shall also be tested as an apparatus in category II while it is connected to the mains network.(For toys, examples include musical soft toys, cord-controlled toys and motor-operated electronic toys.)
Category IV: All other apparatus covered by the scope of the EN 55014-2 standard.
 equency: Fundamental frequency of any signal used in the device, excluding those which are solely de integrated circuits (IC).

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2 **DESCRIPTION OF TEST SETUP**

2.1 Operating mode(s) used for tests

During the tests the following operating mode(s) has(have) been used.

Operating mode	Operating mode description	Used for testing			
mode	Operating mode description	Emission	Immunity		
1	The EUT operates normally.	\boxtimes	\boxtimes		
2					
3					
4					
5					
Supplemen	tal information:				

2.2 Port(s) of the EUT

	Connected to /	Cable				
Port name and description	Termination		Attached	Shielded		
			during test	Silielaea		
AC input port	AC mains	0.8 m	\boxtimes			
Supplemental information:						

2.3 Support / Auxiliary equipment / unit / software for the EUT

The EUT has been tested with the following auxiliary equipment / unit / software:

Auxiliary equipment / unit / software	Type / Version	Manufacturer	Supplied by				
N/A			Applicant				
			DEKRA				
Supplemental information:							

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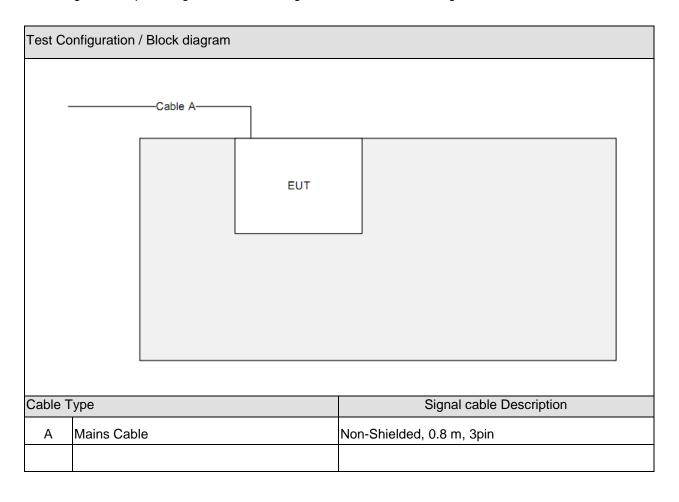
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2.4 Test Configuration / Block diagram used for tests

The following test setup / configuration / block diagram has been used during the tests:



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3 VERDICT SUMMARY SECTION

This chapter presents an overview of standards and results. Refer to the next chapters for details of measured test results and applied test levels.

3.1 Standards

Standard	Year	Description
EN 55014-1	2006	Requirements for household appliances, electric tools and similar apparatus –
A1	2009	Part 1: Emission.
A2	2011	
EN 55014-1	2017	
EN 55016-2-1	2014	Methods of measurement of disturbances and immunity - Conducted
		disturbance measurements.
EN 55016-2-2	2010	Methods of measurement of disturbances and immunity - Measurement of
		disturbance power.
EN 55016-2-3	2010	Methods of measurement of disturbances and immunity - Radiated disturbance
+A1	2010	measurements.
+A2	2014	
EN 61000-3-2	2014	Limits for harmonic current emissions (equipment input current ≤ 16 A per
		phase).
EN 61000-3-3	2013	Limitation of voltage changes, voltage fluctuations and flicker in public low-
		voltage supply systems, for equipment with rated current ≤ 16 A per phase and
		not subject to conditional connection.
EN 55014-2	2015	Requirements for household appliances, electric tools and similar apparatus -
		Part 2: Immunity – Product family standard.
EN 61000-4-2	2009	Electrostatic discharge immunity test.
EN 61000-4-3	2006	Radiated, radio-frequency, electromagnetic field immunity test.
+A1	2008	
+A2	2010	
EN 61000-4-4	2012	Electrical fast transient/burst immunity test.
EN 61000-4-5	2014	Surge immunity test.
EN 61000-4-6	2014	Immunity to conducted disturbances, induced by radio-frequency fields.
EN 61000-4-11	2004	Voltage dips, short interruptions and voltage variations immunity tests.
EN 50498	2010	Product family standard for aftermarket electronic equipment in vehicles

3.2 Deviation(s) from the Standard(s) / Test Specification(s)

The following deviation(s) was / were made from the published requirements of the listed standards:

N/A.

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3.3 Overview of results

EMISSION TESTS – EN 55014-1						
Requirement – Test case	Basic standard(s)	Verdict	Remark			
Conducted disturbance voltage at mains terminals (150 KHz – 30 MHz)	EN 55016-2-1	PASS				
Conducted disturbance voltage at load terminals (150 KHz – 30 MHz)	EN 55016-2-1	N/A				
Conducted disturbance voltage at additional terminals (150 KHz – 30 MHz)	EN 55016-2-1	N/A				
Disturbance power (30 MHz to 300 MHz)	EN 55016-2-2	PASS	See 3)			
Radiated electromagnetic disturbances (30 - 1000 MHz)	EN 55016-2-3	N/A				
Radiated disturbances	EN 50498	N/A				
Conducted transient disturbances	EN 50498	N/A				
Discontinuous disturbance (clicks) on AC power leads	EN 55014-1	N/A	See 1)			

Supplementary information:

- 1) Exemptions from click measurements applicable (clause 4.2.3).
- 2) Not applicable because no test requirements have been specified for DC/battery powered apparatus.
- 3) According to clause 4.3.4.2 procedure (a) of the CISRP 14-1 standard the EUT is deemed to comply in the frequency range from 300 MHz to 1000 MHz without further measurements.

EMISSION TESTS – EN 61000-3-2, EN 61000-3-3						
Requirement – Test case Basic standard(s) Verdict Remark						
Harmonic current emissions	EN 61000-3-2	PASS				
Voltage changes, voltage fluctuations and flicker	EN 61000-3-3	PASS				

Supplementary information:

- 1) The EUT is regarded as an "Equipment with rated power of ≤ 75 W". According to "Clause 7, Figure 1 Flowchart for determining conformity" the EUT is deemed to comply with the requirements of the EN 61000-3-2 standard.
- 2) The EUT is regarded as a professional equipment with a total rated power greater than 1 KW. The test is not applicable.

IMMUNITY TESTS – EN 55014-2						
Requirement – Test case	Basic standard(s)	Verdict	Remark			
Electrostatic discharge	EN 61000-4-2	N/A				
Radio-frequency electromagnetic fields	EN 61000-4-3	N/A				
Fast transients	EN 61000-4-4	N/A				
Surge transient	EN 61000-4-5	N/A				
Injected currents (radio-frequency common mode)	EN 61000-4-6	N/A				
Voltage dips and short interruptions	EN 61000-4-11	N/A				

Supplementary information:

- 1) Not applicable because no test requirements have been specified for DC/battery powered apparatus.
- 2) The equipment is classified as category 1 equipment according to EN 55014-2; no immunity tests are applicable.

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PASS

VERDICT:

4 **EMISSION TEST RESULTS**

4.1 Conducted dis	VERDICT:	PASS	
	,		
Standard	EN 55014-1		
Basic standard	EN 55016-2-1		

Limits

4 1

Frequency range [MHz]	Limit: QP [dB(μV) ¹⁾]	Limit: AV [dB(μV) ¹⁾]	IF BW	Detector(s)
0,15 - 0,50	66 – 56 ²⁾	59 - 46 ²⁾	9 KHz	QP, CAV
0,50 - 5,0	56	46	9 KHz	QP, CAV
5,0 - 30	60	50	9 KHz	QP, CAV

¹⁾ At the transition frequency, the lower limit applies.

Performed measurements

Footo el torresis el/o\ / cont		AC		N.		1.4		1.0		1.0
Tested terminal(s) / port		AC mains input power	\boxtimes	N 🛛 🖂 L1			L2	Ш	L3	
		DC mains input power		Positi	ve (+)			Negative (-)		
	ı									
Voltage – Mains [V]	230 \	0 Vac								
Frequency – Mains [Hz]	50 H	50 Hz								
		1								
Test method applied		Artificial mains network	Artificial mains network							
		Voltage probe								
Test setup	\boxtimes	Table top		Artific	ial har	nd app	lied			
		Floor standing		Other	:					
	Refe	r to the Annex 3 for test se	tup ph	oto(s).	i					
Operating mode(s) used	Mode 1									
Remark										
Operating mode(s) used	Refe	Floor standing								

See next page.

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²⁾ The limit decreases linearly with the logarithm of the frequency.

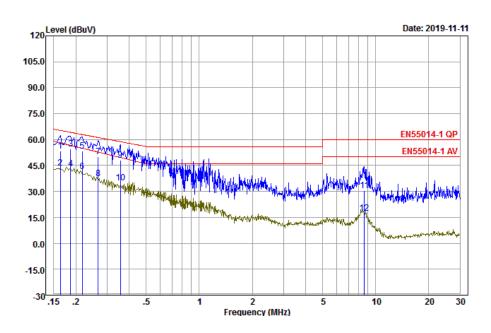
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Measurement data	Port under test	AC input power
Operating mode / voltage / frequency used	Mode 1 / 230 Vac / 50 Hz	

Line:



		Limit		ĸeaa		capie	over	
	Freq	Line	Level	Level	Factor	Loss	Limit	Remark
	MHz	dBuV	dBuV	dBuV	dB	dB	dB	
1	0.16	65.30	53.24	43.59	9.65	0.02	-12.06	QP
2	0.16	58.08	43.44	33.79	9.65	0.02	-14.64	Average
3	0.19	64.20	54.55	44.89	9.66	0.02	-9.65	QP
4 av	0.19	56.65	43.15	33.49	9.66	0.02	-13.50	Average
5 pp	0.22	62.92	53.36	43.70	9.66	0.02	-9.56	QP
6	0.22	55.00	41.36	31.70	9.66	0.02	-13.64	Average
7	0.27	61.20	50.07	40.40	9.67	0.02	-11.13	QP
8	0.27	52.76	37.57	27.90	9.67	0.02	-15.19	Average
9	0.36	58.78	47.99	38.30	9.69	0.03	-10.79	QP
10	0.36	49.62	34.79	25.10	9.69	0.03	-14.83	Average
11	8.64	60.00	30.55	20.60	9.95	0.12	-29.45	QP
12	8.64	50.00	17.35	7.40	9.95	0.12	-32.65	Average

Note

- 1. All Readings are performed with Quasi-Peak and/or average measurements as necessary.
- 2. Measurement Level = Reading Level + Factor +Cable Loss.

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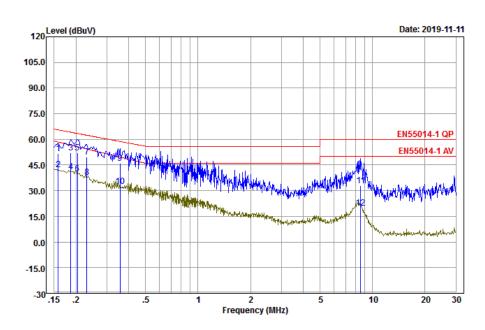
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Measurement data	Port under test	AC input power
Operating mode / voltage / frequency used during the test		Mode 1 / 230 Vac / 50 Hz

Neutral:



	Freq	Line	Level	Level	Factor	Loss	Limit	Remark
	MHz	dBuV	dBuV	dBuV	dB	dB	dB	
1	0.16	65.56	51.54	41.90	9.64	0.02	-14.02	QP
2	0.16	58.43	42.34	32.70	9.64	0.02	-16.09	Average
3	0.19	64.20	51.95	42.29	9.66	0.02	-12.25	QP
4	0.19	56.65	40.95	31.29	9.66	0.02	-15.70	Average
5 pp	0.20	63.45	51.96	42.30	9.66	0.02	-11.49	QP
6 av	0.20	55.68	40.06	30.40	9.66	0.02	-15.62	Average
7	0.23	62.44	49.77	40.11	9.66	0.02	-12.67	QP
8	0.23	54.37	37.97	28.31	9.66	0.02	-16.40	Average
9	0.36	58.78	45.99	36.30	9.69	0.03	-12.79	QP
10	0.36	49.62	32.69	23.00	9.69	0.03	-16.93	Average
11	8.55	60.00	32.75	22.80	9.95	0.12	-27.25	QP
12	8.55	50.00	20.05	10.10	9.95	0.12	-29.95	Average

Read

Cable

0ver

Note:

1. All Readings are performed with Quasi-Peak and/or average measurements as necessary.

Limit

2. Measurement Level = Reading Level + Factor +Cable Loss.

Remark	

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	4.2	Disturbance power (30 MHz – 300 MHz)	VERDICT:	PASS
--	-----	--------------------------------------	----------	------

Standard	EN 55014-1
Basic standard	EN 55016-2-2

Limits

Frequency range [MHz]	Limit: QP [dB(pW)]	Limit: AV [dB(pW)]	IF BW	Detector(s)			
30 - 300	45 – 55 ¹⁾	35 – 45 ¹⁾	120 KHz	QP, CAV			
Margin							
200 - 300	0 - 10 1)		120 KHz	QP, CAV			
1) The limit increases linearly with	1) The limit increases linearly with the frequency.						

Performed measurements

Port(Port(s) under test							
\boxtimes	AC mains input power			Load				Control
	Other:			Other:				Other:
Volta	ge – Mains [V]	230 Vac						
Frequ	uency – Mains [Hz]	– Mains [Hz] 50 Hz						
Test	setup	\boxtimes	Table top			standing		
			Othe	r:				
		Refer	to the	Annex 3 for test se	tup ph	oto(s).		
	litions for exemption measurements above	\boxtimes	"Limit	ts" reduced by "Mar	gin" ap	plied a	and pa	ssed
300 N		\boxtimes	Maximum clock frequency < 30 MHz					
Oper	ating mode(s) used	Mode	ode 1					
Rem	ark							

See next page.

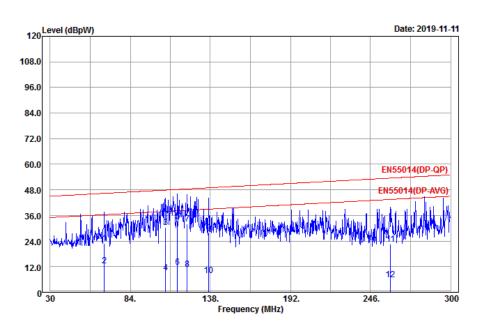
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Measurement data	Port under test	AC input power
Operating mode / voltage / frequency used	d during the test	Mode 1 / 230 Vac / 50 Hz



	Freq	Limit Line	Level	Read Level	Factor	Cable Loss	Over Limit	Remark	
	MHz	dBpW	dBpW	dBpW	dB	dB	dB		
1	66.45	46.36	22.87	-2.68	25.55	0.65	-23.49	QP	
2 av	66.45	36.36	12.27	-13.28	25.55	0.65	-24.09	Average	
3	107.76	47.89	30.56	6.22	24.34	0.82	-17.33	QP	
4	107.76	37.89	9.06	-15.28	24.34	0.82	-28.83	Average	
5 pp	115.86	48.19	33.36	9.31	24.05	0.85	-14.83	QP	
6	115.86	38.19	11.86	-12.19	24.05	0.85	-26.33	Average	
7	122.34	48.43	32.06	8.12	23.94	0.87	-16.37	QP	
8	122.34	38.43	10.86	-13.08	23.94	0.87	-27.57	Average	
9	136.92	48.97	27.68	3.61	24.07	0.92	-21.29	QP	
10	136.92	38.97	7.88	-16.19	24.07	0.92	-31.09	Average	
11	259.50	53.51	22.47	-0.20	22.67	1.27	-31.04	QP	
12	259.50	43.51	5.77	-16.90	22.67	1.27	-37.74	Average	

Note

- 1. All Readings are performed with Quasi-Peak and/or average measurements as necessary.
- 2. Measurement Level = Reading Level + Factor +Cable Loss.

Remark	According to c	lause	4.3.4.2

Appliances are deemed to comply in the frequency range from 300 MHz to 1 000 MHz if both of the following conditions (1) and 2)) are fulfilled:

- 1) All emission readings from the equipment under test shall be lower than the applicable limits reduced by the margin;
- 2) The maximum clock frequency shall be less than 30 MHz;

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4.3 Radiated electromagnetic disturbances (30 – 1000 MHz) VERDICT: N/A

Standard	EN 55014-1
Basic standard	EN 55016-2-3
Test method	Antenna method according to EN 55016-2-3 standard.

Limits

Frequency	I	Limit: QP [dB(μV/m) ¹⁾]	IE DW	Detector
[MHz]	@3 m.	@5 m.	@10 m.	IF BW	Detector
30 - 230	40	36	30	120 KHz	QP
230 - 1000	47	43	37	120 KHz	QP
1) At the transition frequency, the	lower limit applies.				

Performed measurements

Port under test	Enclo	Enclosure					
Voltage - Mains [V]							
Frequency - Mains [Hz]							
Test method applied		OATS or SAC with measurement distance [m]: 3 m.					
		OATS or SAC with measurement distance [m]: 5 m.					
		OATS or SAC with measurement distance [m]: 10 m.					
Test setup	\boxtimes	Equipment on a table of 80 cm height					
		Equipment on the floor (insulated from ground plane)					
		Other:					
	Refer to the Annex 3 for test setup photo(s).						
Operating mode(s) used	Operating mode(a) yeard Mode 4						
	IVIOUE	Mode 1					
Remark							

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4.4 Discontinuous disturbance (clicks) on AC power leads VERDICT: N/A

Standard	EN 55014-1		
Frequency [MHz]	Limit: QP [dB(μV)]	IF BW	Detector
0,15	66	9 KHz	Quasi-Peak (QP)
0,50	56	9 KHz	Quasi-Peak (QP)
1,40	56	9 KHz	Quasi-Peak (QP)
30,0	60	9 KHz	Quasi-Peak (QP)

Performed measurements

	one medicar ements											
Voltage – Mains [V] 230 Vac												
Frequency -	Mains [Hz]		50 Hz	, 60 Hz	<u>-</u>							
Test method applied [Artificial mains network								
			<u> </u>	Voltage	e probe							
Test setup			\square	Table t	op			-loor sta	nding			
		_		Other:								
			Refer t	o the /	\nnex :	3 for test setu	ı p pho	io(s).				
Operating me	odo(s) usod		Mode 1	1								
Remark	Juc(s) useu			-								
Neman												
Reason for n		\boxtimes		•		the observence, these ar					low th	e limit for
Measuremen	nt results	\boxtimes	Neutra	ļ		Line 1	E	Line) 2		Line	3
F	First Measurement: Determination of the limit L _q - Quasi-peak											
Frequency (MHz)	Limit L (dBµV)		Number of short clicks		ber of clicks	Number of clicks – N ₁	Time of meas. (min.)		Click rate N	Incre limit		Increased Limit Lq
						_	120		5	1	6	82
0,15	66	(0	(9	0	=	120			U	
0,15 0,5	66 56		0 0) Э	0			5	1	6	72
		((-	4					72 72
0,5	56	(9	(9	0	4	20	5	1	6	· -
0,5 1,4	56 56 60 The calcul	ated cli	9 9 0 ick rate s). Thu	Wis nus, the	ot mor	0	4 4 es per	20 20 20 20 minute (5 5 5 and all the	1 1 clicks	6 6 6 are c	72 76
0,5 1,4 30 ⊠	56 56 60 The calcul short (t ≤	ated cli	0 0 0 ick rate s). Thu	N is nus, the	ot mor EUT- imit.	0 0 0 0	4 2 es per to cor	20 20 20 20 minute and poly with the second	5 5 and all the	1 2 clicks	6 6 6 are c	72 76
0,5 1,4 30	56 56 60 The calcul short (t ≤	ated cli	0 0 0 ick rate s). Thu	N is nus, the eased I	ot more EUT imit.	0 0 0 0 e than 5 time is deemed	1 4 4 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	20 20 20 20 minute and	5 5 5 and all the h the lim	1 2 clicks hits wit	6 6 6 are chout	72 76
0,5 1,4 30 ☐	56 56 60 The calcul short (t ≤ measurerr	ated cli	0 0 0 ick rate s). Thu an incre Secon	N is nus, the eased I	ot more EUT imit.	0 0 0 0 e than 5 time is deemed	1 4 4 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	20 20 20 20 minute and	5 5 5 and all the h the lim	1 2 clicks hits wit	6 6 6 are chout	72 76 lassified as
0,5 1,4 30 ☐ Frequency (MHz)	56 56 60 The calcul short (t ≤ measurerr	ated cli	0 0 0 ick rate s). Thu an incre Secon	N is nus, the eased I	ot more EUT imit.	0 0 0 0 e than 5 time is deemed	1 4 4 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	20 20 20 20 minute and	5 5 5 and all the h the lim	1 2 clicks hits wit	6 6 6 are chout	72 76 lassified as
0,5 1,4 30 ☐ Frequency (MHz) 0,15	56 56 60 The calcul short (t ≤ measurerr	ated cli	0 0 0 ick rate s). Thu an incre Secon	N is nus, the eased I	ot more EUT imit.	0 0 0 0 e than 5 time is deemed	1 4 4 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	20 20 20 20 minute and	5 5 5 and all the h the lim	1 2 clicks hits wit	6 6 6 are chout	72 76 lassified as
0,5 1,4 30 ☐ Frequency (MHz) 0,15 0,5	56 56 60 The calcul short (t ≤ measurerr	ated cli	0 0 0 ick rate s). Thu an incre Secon	N is nus, the eased I	ot more EUT imit.	0 0 0 0 e than 5 time is deemed	1 4 4 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	20 20 20 20 minute and	5 5 5 and all the h the lim	1 2 clicks hits wit	6 6 6 are chout	72 76 lassified as

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4.5 Harmonic current emissions						VERDICT:	PASS			
Standar	rd	EN 610	EN 61000-3-2							
Exlusio	ns		Arc welding equipment intended for professional use.							
	ese categories of		System(s) with nominal voltage(s) less than 220 V _{AC} (line-to-neutral).							
	ent, limits are not ed in the EN 61000-		Equipment with	rated p	ower of ≤ 75 W (o	ther tha	ın lighting equip	ment).		
3-2 star	ndard)		Professional eq	uipmen	t with total rated p	ower >	1 kW.			
			Symmetrically of	controlle	ed heating element	ts with a	a rated power ≤	200 W.		
			Independent dir	mmers f	for incandescent la	amps wi	th rated power	≤ 1 kW.		
Classific	cation									
\boxtimes	Class A	All app	aratus not classit	fied as (Class B, C or D					
	Class B	Portab	le tools, arc weld	ding eq	uipment which is	s not pr	rofessional eq	uipment.		
			Lighting equipm	nent witl	h active input powe	er > 25	W			
	Class C		Lighting equipment with active input power ≤ 25 W (First requirement, Table 3 column 2)							
			Lighting equipment with active input power ≤ 25 W (Second requirement)							
	Class D				receivers, refrige es to control com			aving one		
Perform	ed measurements									
Port und	der test	AC ma	AC mains power input							
Voltage	e – Mains [V]	230 Vac								
Frequer	ncy – Mains [Hz]	50Hz								
Observa	ation peroid		6.5 min.	\boxtimes	2.5 min.	T	Other:			
	of measurement	\boxtimes	EN 61000-4-7:2	2002 + /	AM1:2009 (IEC 61	000-4-7	7:2002+AM1:20	08)		
	ent standard used C61000-4-7 (Cl. 7)		EN 61000-4-7:1	1991						
	principle used in		Comply with the	e require	ements of the Clau	use 6.1	(EN / IEC 6100	0-3-2).		

See next page.

Operating mode(s) used

Mode 1

the EUT

Remark

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Not comply with the requirements of the Clause 6.1 (EN / IEC 61000-3-2).

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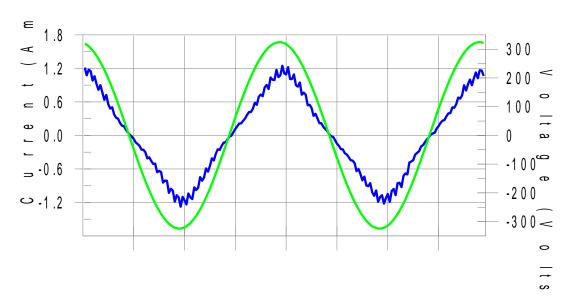
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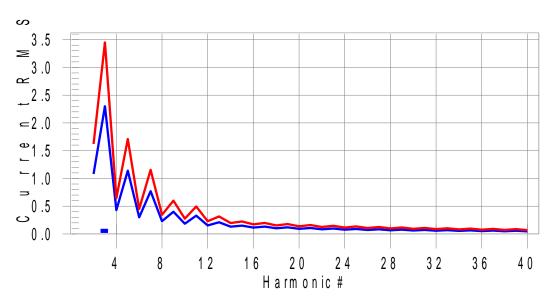
Measurement data	Port under test	AC input power
Operating mode / voltage / frequency used	Mode 1 / 230 Vac / 50 Hz	

Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class A limit line European Limits



Test result: Pass Worst harmonics H3-2.8% of 150% limit, H3-3.9% of 100% limit

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Measur	ement data			Port under test	AC input pow	er er		
	Test Result: Pass Source qualification: Normal THC(A): 0.090 I-THD(%): 12.6 POHC(A): 0.003 POHC Limit(A): 0.251							
` ′	t parameter valu	` ,		(11)		.,. 0.201		
3	V_RMS (Volts): I_Peak (Amps):			Frequency(H				
	I_Fund (Amps):	0.715		Crest Factor:	1.821			
	Power (Watts):	163.7		Power Factor			.	
Harm#	Harms(avg) 10				150%Limit			
2 3	0.001 0.089	1.080 2.300	N/A 3.9			N/A 2.8	Pass Pass	
4	0.001	0.430	N/A			N/A	Pass	
5	0.008	1.140	0.7			0.5	Pass	
6	0.001	0.300	N/A			N/A	Pass	
7 8	0.004 0.001	0.770 0.230	N/A N/A			N/A N/A	Pass Pass	
9	0.003	0.400	N/A			N/A	Pass	
10	0.001	0.184	N/A	0.001	0.276	N/A	Pass	
11	0.002	0.330	N/A			N/A	Pass	
12 13	0.001 0.003	0.153 0.210	N/A N/A			N/A N/A	Pass Pass	
14	0.003	0.131	N/A			N/A	Pass	
15	0.002	0.150	N/A	0.003	0.225	N/A	Pass	
16	0.001	0.115	N/A			N/A	Pass	
17 18	0.002 0.001	0.132 0.102	N/A N/A			N/A N/A	Pass Pass	
19	0.001	0.102	N/A			N/A N/A	Pass	
20	0.001	0.092	N/A	0.001	0.138	N/A	Pass	
21	0.001	0.107	N/A			N/A	Pass	
22 23	0.001 0.001	0.084 0.098	N/A N/A			N/A N/A	Pass Pass	
24	0.001	0.038	N/A			N/A	Pass	
25	0.001	0.090	N/A			N/A	Pass	
26	0.002	0.071	N/A			N/A	Pass	
27 28	0.001 0.001	0.083 0.066	N/A N/A			N/A N/A	Pass	
26 29	0.001	0.008	N/A N/A			N/A N/A	Pass Pass	
30	0.001	0.061	N/A		0.092	N/A	Pass	
31	0.001	0.073	N/A			N/A	Pass	
32 33	0.001 0.001	0.058 0.068	N/A N/A			N/A N/A	Pass Pass	
34	0.001	0.054	N/A			N/A	Pass	
35	0.001	0.064	N/A			N/A	Pass	
36	0.001	0.051	N/A			N/A	Pass	
37 38	0.001 0.001	0.061 0.048	N/A N/A			N/A N/A	Pass Pass	
39	0.001	0.048	N/A			N/A N/A	Pass	
40	0.001	0.046	N/A			N/A	Pass	
Remark	·							
	•							

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4.6 Voltage changes	4.6 Voltage changes, voltage fluctuations and flicker VERDICT: PASS							
Standard	EN 610	000-3-3						
Limits								
P _{ST} (Short term flicker)	\boxtimes	≤ 1				Not Appli	cable	
P _{LT} (Long term flicker)	\boxtimes	≤ 0,65				Not Appli	cable	
dc (Relative Voltage change)	\boxtimes	≤ 3,3%				Not Appli	cable	
T _{MAX} (Maximum time duration)		500ms				Not Appli	cable	
d _{MAX} (Max. voltage change)	\boxtimes	≤ 4%				6%		
		7%				Not Appli	cable	
Supplemental information:								
Performed measurements Reason for not performing the measurement(s)		Tests are r		•			UT is unlikely use 6.1).	to produce
Port under test	AC Ma	ins power inp	ut					
Voltage – Mains [V]	230 Va	ıc						
Frequency – Mains [Hz]	50Hz							
Test method		Flickermeter	accord	ing EN	/ IEC 6	31000-4-15	:2011	
		Simulation (Clause	4.2.3 o	f EN / II	EC 61000-	3-3)	
		Analytical m	ethod ((Clause	4.2.4 o	f EN / IEC	61000-3-3)	
		Use of P _{st} =	1 curve	(Claus	e 4.2.5	of EN / IE	C 61000-3-3)	
Observation peroid	\boxtimes	10 min.		120 m	in.		Other:	
		24 times swi	itching a	accordi	ng to A	nnex B		
Operating mode(s) used	Mode	1						

See next page.

Remark

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Measurement data	Port under test	AC input power
Operating mode used during the test	Mode 1 / 230 Vac	/ 50 Hz

Results

Tmax (dt > 3,3%)	0,0 ms
Maximum relative voltage change d _{MAX}	0.62%
Relative Voltage change dc	<0,050%
Short term flicker P _{ST}	0.143
Long term flicker P _{LT}	0,00

Remark ---

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5 **IMMUNITY TEST RESULTS**

5.1 Performance (Compliance) criteria

[According to EN 55014-2 (CISPR 14-2)]

<u>Performance criteria A:</u> The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer when the apparatus is used as intended. If the minimum performance level or the permissible performance loss is not specified by the manufacturer then either of these may be derived from the product description and documentation and from what the user may reasonably expect from the apparatus if used as intended.

<u>Performance criteria B</u>: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer when the apparatus is used as intended. During the test, degradation of performance is allowed however no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer then either of these may be derived from the product description and documentation and from what the user may reasonable expect from the apparatus if used as intended.

<u>Performance criteria C:</u> Temporary loss of function is allowed provided the function is self- recoverable or can be restored by the operation of the controls or by any operation specified in the instruction for use.

5.1.1 Performance criteria related to immunity tests

Immunity test	Performance criteria
Electrostatic discharge	В
Radio-frequency electromagnetic fields	А
Fast transients	В
Surge transient	В
Injected currents (radio-frequency common mode)	А
Voltage dips and short interruptions	С

5.1.2 Manufacturer defined performance criteria

Not provided.

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5.2	Monitored – Checked Functions / Parameters							
During	During the immunity tests the following functions of the EUT has/have been monitored/checked.							
	Motor speed		Display data					
	Switching		Data storage					
	Standby mode		Sensor functions					
	Temperature		Audible signals					
\boxtimes	Power consumption		Others: LED's					
	AC mains input current		Others:					
	Timing		Others:					
	☐ Illumination ☐ Others :							
Supp	Supplementary information :							

Immunity test	Monitored - Checked function(s)/parameter(s) during / after the test	Method
Electrostatic discharge		Visual
Radio-frequency electromagnetic fields		Visual / Camera
Fast transients		Visual
Surge transient		Visual
Injected currents (radio-frequency common mode)		Visual
Voltage dips and short interruptions		Visual
Supplementary information :		

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	5.3	Electrostatic discharge immunity	VERDICT:	N/A
--	-----	----------------------------------	----------	-----

Electrostatic discharges (ESD) are the result of persons or objects that accumulate static electricity due to for instance walking on synthetic carpets. The ESD can influence the operation of equipment or damage its electronics, either by a direct discharge or indirectly by coupling or radiation. Both effects are simulated during the tests.

Requirements

Standard	EN 55014-2					
Basic standard	EN 61000-4-2					
Port under test	Enclosure					
Air discharges 1)	☐ ±2 kV ☐ ±4 kV ☐ kV					
Contact discharges 1)	☐ ±2 kV ☐ ±4 kV ☐ kV					
Number of discharges	≥ 10 per polarity with ≥ 1 sec interval.					
1) Tests with lower voltages are not required.						

Performed tests

Set-up	☐ Table-top	Floor standing
Ambient temperature [°C]	20.7- 22.8°C	Relative Humidity air [%] 46.5-46.7%
Voltage - Mains [V]		
Frequency - Mains [Hz]		
Operating mode(s) used	Mode 1,2	

	Test l	Point	Test Voltage [kV] -& Polarity	Coupling type	# of applied discharges / polarity	Discharge interval [s]	
\boxtimes	Points on cond	luctive surface.	±4	Contact	10	1	
\boxtimes	Points on non-	conductive surface.	±8	Air	10	4	
\boxtimes	HCP top side.		±4	Contact	10	4	
\boxtimes	HCP bottom si	de.	±4	Contact	10	1	
\boxtimes	VCP right side.		±4	Contact	10	1	
\boxtimes	VCP left side.		±4	Contact	10	1	
\boxtimes	VCP front side.	-	±4	Contact	10	1	
✓ VCP rear side. ±4 Contact 10					10	1	
Obse	Observation(s) During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance or data was observed.						

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5.4 Radio-frequency electromagnetic fields immunity VERDICT: N/A

During the test it is verified if the equipment under test (EUT) has sufficient immunity against radiated electromagnetic fields. Industrial electromagnetic sources, walkie-talkies, radio transmitters, television transmitters and telecommunication equipment including cellular telephones and other emitting devices can generate these fields.

Requirements

Standard	EN 55014-2						
Basic standard	EN 61000-4-3	N 61000-4-3					
Port under test	Enclosure						
Frequency range	Test level	Modulation	Dwell time	Step size			
80 – 1000 MHz	3 V/m	80% AM (1kHz)	≥ 0,5 s	≤ 1%			
Supplementary information:	<u>:</u>						

Performed tests

Performed tests					T			
Test method								
Test set-up	\boxtimes	Equipment on the table (0,8 m height)						
(see Annex 3 for photo)	\Box	Equipment standing on floor (0,05 – 0,15 m height)						
Voltage – Mains [V]								
Frequency - Mains [Hz]								
Operating mode(s) used	Mode	Mode 1,2						
Frequency range (applied)		ntenna arization	Test level (applied)		Modulation (applied)	Dwell time (applied)		Remark
80 – 1000 MHz		Ħ	3 V/m 80% AM (1kHz)		3 s			
(step size 1%)		¥	3 V/i	m	80% AM (1kHz)	,	3 s	
Exposed side of the EUT		Front (0)		Right (90°)		Top	
		Rear (18	30°)	\boxtimes	Left (270°)		Bottom	+
Observation(s) During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance was observed.								
Supplementary information	·							

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5.5 Electrical Fas	t Transients immunity	VERDICT: N/A
--------------------	-----------------------	--------------

The EFT immunity test simulates disturbances by bursts of very short transients caused for example by switching off loads such as an AC motor or bouncing relay contacts. The transients are likely to disturb electronics but less likely to cause damage.

Requirements

•						
Standard EN 55014-2						
Basic standard EN 61000-4-4						
Pulse characteristics 5/50 ns						
Port		Test level	Repetition frequency	Duration		
\boxtimes			± 1000 V	5 KHz	1 min. / polarity	
☐ DC input-output power ²⁾			± 500 V	5 KHz	1 min. / polarity	
☐ Signal and Control lines ³⁾			± 500 V	5 KHz	1 min. / polarity	
1) For	extra low voltage a.c ports,	this testing is only applicable	to ports interfacing w	ith cables whos	e total length may	

Performed tests

Voltage – Mains [V]	230 Vac					
Frequency - Mains [Hz]	50Hz	50Hz				
Operating mode(s) used	Mode 1					
Test Set-up	Equipment standing on floor at (0,1 ± 0,01) m above ground plane					
(see Annex 3 for photo)	\boxtimes	Equipment on the table (0,1 ± 0,01) m above ground plane				
		Artificial hand applied. Location refer to Annex 3.				
Coupling	\boxtimes	Common mode		Other:		

Port(s) under test	Test Voltage &Polarity	Repetition Frequency	Test duration / polarity		Injection	meth	od
AC power input	±1 kV	5 KHz	60 s	\boxtimes	CDN		Clamp
AC / DC power output	± 0.5 kV	5 KHz	60 s		CDN		Clamp
Ethernet / LAN		5 KHz	60 s		CDN	\boxtimes	Clamp
Observation(s)		•	rformance was nacceptable loss				
Supplementary information:							

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¹⁾ For extra low voltage a.c ports, this testing is only applicable to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

²⁾ Not applicable to battery operated appliances that cannot be connected to the mains while in use.

³⁾ Applicable only to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

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5.6 Surge transient immunity VERDICT: N/A

The surge transient immunity test simulates the surges that are caused by over-voltages due to indirect (induced) lightning transients. The pulse is a slow transient with high-energy contents and due to its long duration may cause damage to an unprotected EUT.

Requirements

Standard	EN 55014-2				
Basic standard					
Pulse characteristics	3/20µs Current				
Repetition rate	ch test level and phase angle)				
Number of pulses	5 pulses (at each polarity and phase angle)				
Port		Test level & Pol	arity & Coupling	Phase angle	
Poil		Line to Line	Line to Earth	[°]	
AC input power 1)		+ 1 kV	+ 2 kV	90	
AC input power 1)	- 1 kV	- 2 kV	270		
1) Tests with lower voltages are not required.					

Performed tests

Voltage - Mains [V]	230 Vac
Frequency - Mains [Hz]	50Hz
Operating mode(s) used	Mode 1
Repetition rate	60 secs. (for each test level and phase angle)
Number of pulses	5 pulses (at each polarity and phase angle)

	Port(s) under test	Coupling	Test level & Polarity	Phase angle	Remark	
\boxtimes	AC mains input power	Line to Neutral	+1 kV	90		
\square	AC mains input power	Line to Neutral	-1 kV	270		
	AC mains input power	Line to Earth	+2 kV	90		
\Box	AC mains input power	Line to Earth	-2 kV	270		
	AC mains input power	Neutral to Earth	+2 k∀	90		
	AC mains input power	Neutral to Earth	-2 kV	270		
0	t' (-)	During the test no le	ess of performance	was observed. A	fter the test the EUT	
Ubse	ervation(s)	functioned as intended. No unacceptable loss of performance was observed.				
Supp	Supplementary information:					

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5.7 Injected currents (RF common mode) immunity VERDICT: N/A

During this test the immunity of the equipment for induced or conducted electromagnetic fields is checked. Fields generated by radio and other transmitters cause RF voltages in long cables like the mains network. This test reproduces these induced disturbing voltages by injecting them to the EUT via the cabling.

Requirements

Standa	ard	EN 55014-2				
Basic standard EN 61000-4-6						
	Frequency range	Modulation	Step size	Dwell time		
	0,15 – 80 MHz	80% AM (1kHz)	≤ 1%	≥ 0,5 s		
\boxtimes	0,15 – 230 MHz	80% AM (1kHz)	≤ 1%	≥ 0,5 s		
	Port		Test I	evel, <i>U</i> o		
		3 V				
	DC input-output power ^{2) 3)}		1 V			
	Signal and Control lines	4)	1 V			

¹⁾ For extra low voltage a.c ports, this testing is only applicable to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

Performed tests

Frequency rai	Frequency range (applied)			Step size (applied)	
☐ 0,15 — 80 MHz	\boxtimes	0,15 – 230 MHz	80% AM (1kHz)	1%	
Voltage – Mains [V]	230 \	/ac	Frequency – Mains [Hz]	50Hz	
Operating mode(s) used	Mode) 1			
Test set-up		Equipment standing on f	loor at (0,1 ± 0,01) m above	ground plane.	
(see Annex 3 for photo)		Equipment on the table (0,1 ± 0,01) m above ground plane.			
		Artificial hand applied. Location refer to Annex 3.			

Port(s) under test		Test Level (applied)	Injection method	Dwell time (applied)	Remark
AC input power		3∀	CDN-M2/3	3s	
Ethernet / LAN		3∀	RF-Injection Clamp	3s	
Observation(s) During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance was observed. Supplementary information:					

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²⁾ Not applicable to battery operated appliances that cannot be connected to the mains while in use.

³⁾ Applicable to battery operated appliances that can be connected to the mains while in use, or to appliances for which the length of d.c. cables may exceed 3 m according to the manufacturer's functional specification.

⁴⁾ Applicable only to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

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5.8 Power supply interruptions and dips immunity VERDICT: N/A

The purpose of the test is to verify the immunity of the equipment against voltage dips and voltage interruptions. It helps to ensure that the equipment functions properly (as expected and safely) with power supply fluctuations. Voltage dips and interruptions are caused by faults in the LV, MV, HV networks (short-circuit or ground faults).

Requirements

Standard	EN 55014-2				
Basic standard	EN 61000-4-11				
# of dips & interruptions	3 dips / interrupti	ons for eac	h test leve	el and phase angle	
Interval between events	≥ 10 seconds				
Port	Test level 1)	Period (Cycles)		Performance Criterion	
Port		50 Hz	60 Hz	Performance Citterion	
AC input power port	U _{NOM} – 100%	0,5	0,5	C; Refer to the chapter 5.1 for details.	
AC input power port	U _{NOM} – 60%	10 12		C; Refer to the chapter 5.1 for details.	
AC input power port	U _{NOM} – 30%	25	30	C; Refer to the chapter 5.1 for details.	

¹⁾ Changes to the voltage level shall occur at a zero crossing point in the a.c. voltage waveform.

NOTE: Where the equipment has a rated voltage range the following shall apply:

- If the voltage range does not exceed 20% of the lower voltage specified for the rated voltage range. A single voltage within that range may be selected for testing.
- In all other cases, the test procedure shall be applied for both the lowest and highest voltages declared in the voltage range.

Performed tests

- Criorinea tests							
U _{NOM} [V _{AC}]	Terminal	Voltage dip	Duration [cycles]		Repetion rate	Number of	Phase angle
ONOM [VAC]	1 Cirriiriai	[% U NOM]	50 Hz	60 Hz	[s]	dips per test	[[⊕]]
240	L-N	0	0,5	0,5	10	3	0, 180
240	L-N	40	10	12	10	3	0, 180
240	L-N	70	25	30	10	3	0, 180
Operating mo	ode(s) used	Mode 1					
Observation(s) During the test no loss of performance was observed. After the test the EU functioned as intended. No unacceptable loss of performance was observed.							
Supplementary information:							

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6 IDENTIFICATION OF THE EQUIPMENT UNDER TEST



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7 ANNEX 1 – MEASUREMENT UNCERTAINTIES

The table(s) below show(s) measurment uncertainties of the EMC test set-ups. The reported expanded uncertainties are based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%.

Emission tests	Emission tests			
Conducted disturbance (mains por	3,08 dB	3,83 dB		
Conducted disturbance using an A	4,04 dB 4,44 dB	4,20 dB 4,59 dB		
Conducted disturbance using a VF	P, 150kHz – 30MHz	1,82 dB	2,91 dB	
Conducted disturbance using a CV	/P, 150kHz – 30MHz	3,44 dB	3,85 dB	
Conducted disturbance using a CF	2,06 dB	2,89 dB		
CDNE, 30MHz – 300MHz	3,34 dB	3,79 dB		
Disturbance power, 30 MHz – 300	MHz	3,76 dB	4,52 dB	
Radiated electromagnetic disturba	nces, (9 KHz – 30 MHz)	2,62 dB	3,3 dB	
Radiated emissions; (Horz.)	30 MHz – 300 MHz	3,60 dB	E 24 dD	
Radiated emissions, (11012.)	300 MHz – 1000 MHz	3,10 dB	5,34 dB	
Radiated emissions: (Vert.)	30 MHz –300 MHz	3,20 dB	6 33 4B	
Radiated emissions; (Vert.) 300 MHz – 1000 MHz		3,20 dB	6,32 dB	
LF harmonic current emissions	0,2%	na		
LF voltage fluctuations	2,5%	na		
EMF		2,02 dB	na	

Immunity tests	Uncertainty
Electrostatic discharge	U _{peak} =6%, U _{30ns} =6%,
Electrostatic discharge	U _{60ns} =6%, U _{rt} =13%
Radio-frequency electromagnetic fields	1,48 dB
Fast transients	$U_{tr}=6,2\%$, $U_{pw}=3\%$, $U_{bp}=3\%$,
rast transients	U _{bd} =3%
Surges	U _{peak} =3,3%, U _{ft} =3%, U _{dt} =3%
Injected currents (radio-frequency common mode)	1,71 dB
Voltage dips and short interruptions	U _{out} =0,4%, U _f =3%, U _{r-d} =3%

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8 ANNEX 2 – USED EQUIPMENT

DEKRA SH

Conducted Emission

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
EMI test receiver	R&S	ESCI	101351	2020/07/18
EMI test receiver	R&S	ESR3	102305	2020/07/18
Artificial Mains Network	R&S	ENV216	101620	2020/08/12
Artificial Mains Network	SCHWARZBECK	NSLK 8128	8128-287	2020/08/09
Asymmetric artificial network	SCHWARZBECK	NTFM8131	8131-151	2020/07/18
Asymmetric artificial network	TESEQ	ISN T800	30306	2020/07/18
High power voltage probe	SCHWARZBECK	TK9421	#308	2020/04/20
Capacitive voltage probe	TESEQ	CVP 2200A	43476	2020/07/18
Current probe	ETS.LINDGREN	91550-1L	218473	2020/08/12

CDNE

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
EMI test receiver	R&S	ESCI	101351	2020/07/18
EMI test receiver	R&S	ESR3	102305	2020/07/18
Coupling/Decoupling Network	SCHWARZBECK	CDNE M3	00088	2019/12/11
Coupling/Decoupling Network	TESEQ	CDN M016S	34640	2020/07/18

Radiated electromagnetic disturbances (9 kHz to 30 MHz)

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
EMI test receiver	R&S	ESCI	101351	2020/07/18
EMI test receiver	R&S	ESR3	102305	2020/07/18
3-dimensional large loop antenna	SCHWARZBECK	HXYZ 9170	HXYZ9170-245	2020/07/18

Disturbance Power

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
EMI test receiver	R&S	ESCI	101351	2020/07/18
EMI test receiver	R&S	ESR3	102305	2020/07/18
EMI absorbing clamp	SCHWARZBECK	MDS 21B	4183	2020/07/25

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Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
EMI test receiver	R&S	ESR3	102305	2020/07/18
Artificial Mains Network	R&S	ENV216	101620	2020/07/18
Artificial Mains Network	SCHWARZBECK	NSLK 8128	8128-287	2020/08/09

Harmonic & Flicker

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
Harmonic currents and flicker tester	California Instruments	CTS	1306A00135	2020/05/14
AC power source	California Instruments	5001iX-CTS-400	1306A00135	2020/05/14
Harmonic currents and flicker tester	TESEQ	Profline 2145	1736A02510	2020/08/09

ESD

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
ESD generator	TESEQ	NSG 435	6716	2020/06/05

EFT, Surge and V-Dips

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
EFT, Surge, DIPS all-in-one	TESEQ	NSG-3040-MF	2006/EFT:0535 /SURGE:1234 /DIPS:2062	2020/05/14

Injected currents

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
Compact immunity test system (RF)	TESEQ	NSG 4070-30	35895	2020/05/14
Coupling decoupling network (CDN)	TESEQ	CDN M016S	34640	2020/05/14
Attenuator	TESEQ	ANT 6050	34847	2020/05/14

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9 **ANNEX 3 – TEST PHOTOS**

Conducted disturbance voltage at mains terminals



Disturbance power



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Harmonic current emissions & Flicker



End of the report

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